

# MOS INTEGRATED CIRCUIT $\mu$ PD23C32343, 23C32383

## 32M-BIT MASK-PROGRAMMABLE ROM 2M-WORD BY 16-BIT PAGE ACCESS MODE

#### **Description**

The  $\mu$ PD23C32343 and  $\mu$ PD23C32383 are 33,554,432 bits mask-programmable ROM. The word organization is 2,097,152 words by 16 bits.

The active levels of OE (Output Enable Input) can be selected with mask-option.

The  $\mu$ PD23C32343 and  $\mu$ PD23C32383 are packed in 48-pin PLASTIC TSOP(I) and 48-pin TAPE FBGA.

#### **Features**

- Pin compatible with NOR Flash Memory
- Word organization
  - 2,097,152 words by 16 bits
- Page access mode
  - 4 word random page access (μPD23C32343)
  - 8 word random page access (µPD23C32383)
- Operating supply voltage : Vcc = 2.7 V to 3.6 V
- Input / output supply voltage : VccQ = 1.65 V to 1.95 V

| Operating supply | Access time /    | Power supply current |             | Standby current    |
|------------------|------------------|----------------------|-------------|--------------------|
| voltage          | Page access time | (Active mode)        |             | (CMOS level input) |
| Vcc              | ns (MAX.)        | mA (MAX.)            |             | μA (MAX.)          |
|                  |                  | μPD23C32343          | μPD23C32383 |                    |
| 3.3 V ± 0.3 V    | 90 / 25          | 40                   | 55          | 30                 |
| 3.0 V ± 0.3 V    | 100 / 25         |                      |             |                    |

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## **Ordering Information**

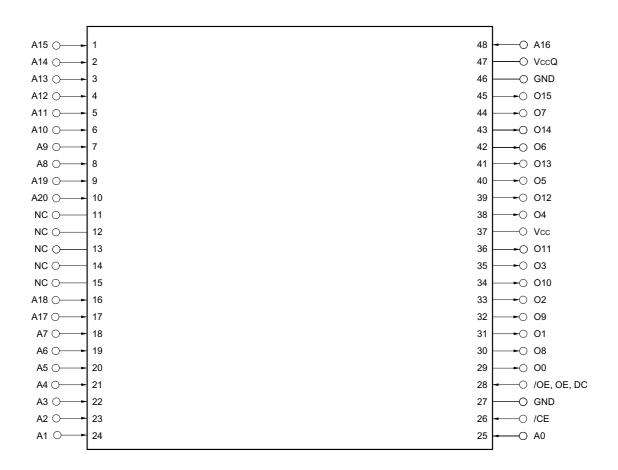
| Part Number                | Package  |
|----------------------------|--|
| $\mu$ PD23C32343GZ-xxx-MJH | 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent) |
| μPD23C32343F9-xxx-BC3      | 48-pin TAPE FBGA (8 x 6)                       |
| $\mu$ PD23C32383GZ-xxx-MJH | 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent) |
| μPD23C32383F9-xxx-BC3      | 48-pin TAPE FBGA (8 x 6)                       |
|                            |  |

(xxx: ROM code suffix No.)

#### Pin Configurations (Marking Side)

/xxx indicates active low signal.

## 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent) [ μPD23C32343GZ-xxx-MJH ] [ μPD23C32383GZ-xxx-MJH ]



A0 - A20 : Address inputs
O0 - O15 : Data outputs
/CE : Chip Enable
/OE, OE : Output Enable
Vcc : Supply voltage

VccQ : Input / output supply voltage

GND : Ground

NC No Connection
DC : Don't Care

**Note** Some signals can be applied because this pin is not connected to the inside of the chip.

Remark Refer to Package Drawings for the 1-pin index mark.

## 48-pin TAPE FBGA (8 x 6) [ $\mu$ PD23C32343F9-xxx-BC3 ] [ $\mu$ PD23C32383F9-xxx-BC3 ]

**Top View Bottom View** 

6

5

4 3 2 0000000 0000000 0000000 00000000 0000000 0000000

BCDEFGH

|   | Α   | В   | С   | D   | Е   | F    | G       | Н   |
|---|-----|-----|-----|-----|-----|------|---------|-----|
| 6 | A13 | A12 | A14 | A15 | A16 | VccQ | O15     | GND |
| 5 | A9  | A8  | A10 | A11 | 07  | O14  | O13     | O6  |
| 4 | NC  | NC  | NC  | A19 | O5  | O12  | Vcc     | 04  |
| 3 | NC  | NC  | A18 | A20 | O2  | O10  | O11     | О3  |
| 2 | A7  | A17 | A6  | A5  | 00  | 08   | O9      | 01  |
| 1 | А3  | A4  | A2  | A1  | A0  | /CE  | /OE, OE | GND |

|   | Н   | G       | F    | E   | D   | С   | В   | Α   |
|---|-----|---------|------|-----|-----|-----|-----|-----|
| 6 | GND | O15     | VccQ | A16 | A15 | A14 | A12 | A13 |
| 5 | O6  | O13     | O14  | 07  | A11 | A10 | A8  | A9  |
| 4 | 04  | Vcc     | O12  | O5  | A19 | NC  | NC  | NC  |
| 3 | O3  | 011     | O10  | O2  | A20 | A18 | NC  | NC  |
| 2 | 01  | O9      | 08   | 00  | A5  | A6  | A17 | A7  |
| 1 | GND | /OE, OE | /CE  | A0  | A1  | A2  | A4  | А3  |

E D C B A

A0 - A20 : Address inputs O0 - O15 : Data outputs /CE : Chip Enable : Output Enable /OE, OE Vcc : Supply voltage

VccQ: Input / output supply voltage

**GND** : Ground

NC Note : No Connection DC : Don't Care

**Note** Some signals can be applied because this pin is not connected to the inside of the chip.

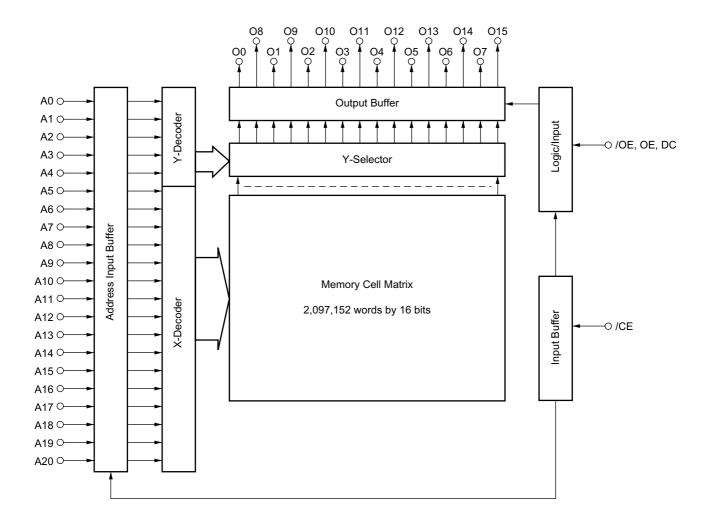
Remark Refer to Package Drawings for the index mark.



## **Input / Output Pin Functions**

| Pin name                    | Input / Output | Function  |
|-----------------------------|----------------|---|
| A0 to A20                   | Input          | Address input pins.   |
| (Address inputs)            |                | A0 to A20 are used as 21 bits address signals.                                      |
| O0 to O15                   | Output         | Data output pins.   |
| (Data outputs)              |                | 16 bits data outputs to O0 to O15.  |
| /CE                         | Input          | Chip activating signal.   |
| (Chip Enable)               |                | When the OE is active, output states are following.                                 |
|                             |                | High level : High impedance   |
|                             |                | Low level : Data out  |
| /OE, OE, DC                 | Input          | Output enable signal. The active level of OE is mask option. The active level of OE |
| (Output Enable, Don't care) |                | can be selected from high active, low active and Don't care at order.               |
| Vcc                         | -              | Supply voltage  |
| VccQ                        | -              | Input / output supply voltage   |
| GND                         | -              | Ground  |
| NC                          | -              | Not internally connected. (The signal can be connected.)                            |

#### **Block Diagram**





#### **Mask Option**

The active levels of output enable pin (/OE, OE, DC) are mask programmable and optional, and can be selected from among "0" "1" x" shown in the table below.

| Option | /OE, OE, DC | OE active level |
|--------|-------------|-----------------|
| 0      | /OE         | L               |
| 1      | OE          | Н               |
| х      | DC          | Don't care      |

Operation modes for each option are shown in the tables below.

#### Operation mode (Option: 0)

| /CE | /OE    | Mode    | Output state   |
|-----|--------|---------|----------------|
| L   | L      | Active  | Data out       |
|     | Н      |         | High impedance |
| Н   | H or L | Standby | High impedance |

#### Operation mode (Option: 1)

| /CE | OE     | Mode    | Output state   |
|-----|--------|---------|----------------|
| L   | L      | Active  | High impedance |
|     | Н      |         | Data out       |
| Н   | H or L | Standby | High impedance |

#### Operation mode (Option : x)

| /CE | DC     | Mode    | Output state   |
|-----|--------|---------|----------------|
| L   | H or L | Active  | Data out       |
| Н   | H or L | Standby | High impedance |

Remark L: Low level input

H: High level input



#### **Electrical Specifications**

#### **Absolute Maximum Ratings**

| Parameter                     | Symbol           | Condition | Rating           | Unit |
|-------------------------------|------------------|-----------|------------------|------|
| Supply voltage                | Vcc              |           | -0.3 to +4.6     | V    |
| Input / output supply voltage | VccQ             |           | -0.3 to +4.6     | V    |
| Input voltage                 | Vı               |           | −0.3 to VccQ+0.3 | V    |
| Output voltage                | Vo               |           | −0.3 to VccQ+0.3 | V    |
| Operating ambient temperature | TA               |           | -10 to +70       | °C   |
| Storage temperature           | T <sub>stg</sub> |           | -65 to +150      | °C   |

Caution Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

#### Capacitance (TA = 25 °C)

| Parameter          | Symbol | Test condition | MIN. | TYP. | MAX. | Unit |
|--------------------|--------|----------------|------|------|------|------|
| Input capacitance  | Сі     | f = 1 MHz      |      |      | 10   | pF   |
| Output capacitance | Со     |                |      |      | 12   | pF   |

#### DC Characteristics (TA = -10 to +70 °C, Vcc = 2.7 to 3.6 V, VccQ = 1.65 to 1.95 V)

| Parameter                 | Symbol | Test conditions                      |                  | MIN.     | TYP. | MAX.       | Unit |
|---------------------------|--------|--------------------------------------|------------------|----------|------|------------|------|
| High level input voltage  | VIH    |                                      |                  | 0.8 VccQ |      | VccQ + 0.3 | ٧    |
| Low level input voltage   | VIL    | VccQ = 1.8 V ± 0.15 V                |                  | -0.3     |      | 0.2 VccQ   | V    |
| High level output voltage | Vон    | $I_{OH} = -100 \ \mu A$              |                  | 0.8 VccQ |      |            | V    |
| Low level output voltage  | Vol    | IoL = 2.1 mA                         |                  |          |      | 0.2 VccQ   | V    |
| Input leakage current     | lu     | V <sub>I</sub> = 0 V to VccQ         | Vi = 0 V to VccQ |          |      | +10        | μΑ   |
| Output leakage current    | ILO    | Vo = 0 V to VccQ, Chip de            | eselected        | -10      |      | +10        | μΑ   |
| Power supply current      | Icc1   | /CE = V <sub>IL</sub> (Active mode), | μPD23C32343      |          |      | 40         | mA   |
|                           |        | lo = 0 mA                            | μPD23C32383      |          |      | 55         |      |
| Standby current           | Іссз   | /CE = Vcc - 0.2 V (Stand             | by mode)         |          |      | 30         | μΑ   |



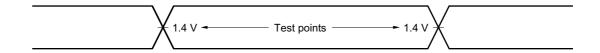
## AC Characteristics (TA = -10 to +70 °C, Vcc = 2.7 to 3.6 V, VccQ = 1.65 to 1.95 V)

| Parameter                 | Symbol       | Test condition | $Vcc = 3.0 V \pm 0.3 V$ |      | $Vcc = 3.3 V \pm 0.3 V$ |      |      | Unit |    |
|---------------------------|--------------|----------------|-------------------------|------|-------------------------|------|------|------|----|
|                           |              |                | MIN.                    | TYP. | MAX.                    | MIN. | TYP. | MAX. |    |
| Address access time       | tacc         |                |                         |      | 100                     |      |      | 90   | ns |
| Page access time          | <b>t</b> PAC |                |                         |      | 25                      |      |      | 25   | ns |
| Chip enable access time   | tce          |                |                         |      | 100                     |      |      | 90   | ns |
| Output enable access time | toe          |                |                         |      | 25                      |      |      | 25   | ns |
| Output hold time          | tон          |                | 0                       |      |                         | 0    |      |      | ns |
| Output disable time       | tor          |                | 0                       |      | 25                      | 0    |      | 25   | ns |

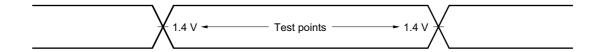
**Remark** top is the time from inactivation of /CE or /OE, OE to high-impedance state output.

#### **AC Test Conditions**

#### Input waveform (Rise / Fall time ≤ 5 ns)



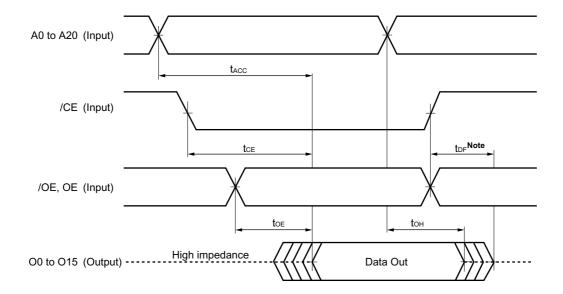
#### **Output waveform**



#### **Output load**

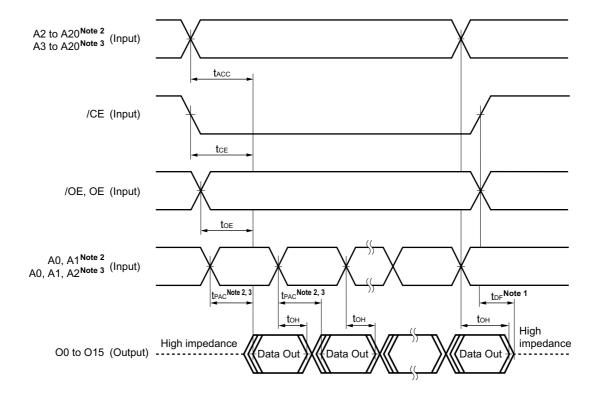
1TTL + 100 pF

#### **Read Cycle Timing Chart 1**



 $\textbf{Note} \quad \mathsf{toF} \ \mathsf{is} \ \mathsf{specified} \ \mathsf{when} \ \mathsf{one} \ \mathsf{of} \ \mathsf{/CE}, \ \mathsf{/OE}, \ \mathsf{OE} \ \mathsf{is} \ \mathsf{inactivated}.$ 

#### Read Cycle Timing Chart 2 (Page Access Mode)



Notes 1. top is specified when one of /CE, /OE, OE is inactivated.

2. The definition of page access time is as follows.

#### [ $\mu$ PD23C32343 ]

| Page access time | Upper address (A2 to A20) | /CE input condition | /OE, OE input condition    |  |
|------------------|---------------------------|---------------------|----------------------------|--|
|                  | inputs condition          |                     |                            |  |
| <b>t</b> PAC     | Before tacc - tpac        | Before tce - tpac   | Before stabilizing of page |  |
|                  |                           |                     | address (A0, A1)           |  |

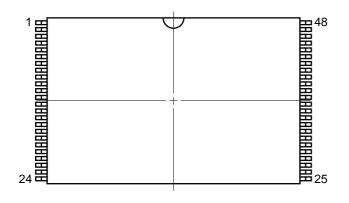
3. The definition of page access time is as follows.

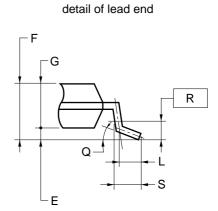
#### [ µPD23C32383 ]

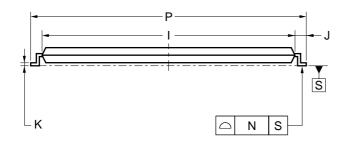
| Page access time | Upper address (A3 to A20) | /CE input condition | /OE, OE input condition    |  |
|------------------|---------------------------|---------------------|----------------------------|--|
|                  | inputs condition          |                     |                            |  |
| <b>t</b> PAC     | Before tacc - tpac        | Before tce - tpac   | Before stabilizing of page |  |
|                  |                           |                     | address (A0, A1, A2)       |  |

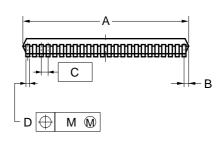
#### **Package Drawings**

## 48-PIN PLASTIC TSOP (I) (12x20)









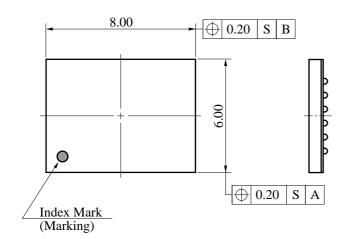
#### **NOTES**

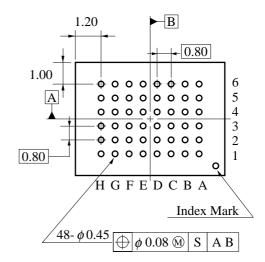
- 1) Each lead centerline is located within 0.10 mm of its true position (T.P.) at maximum material condition.
- 2) "A" excludes mold flash. (Includes mold flash: 12.4 mm MAX.)

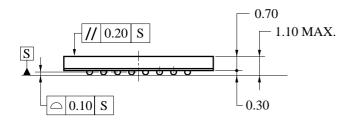
| ITEM | MILLIMETERS  |
|------|--------------|
| A    | 12.0±0.1     |
| В    | 0.45 MAX.    |
| С    | 0.5 (T.P.)   |
| D    | 0.22±0.05    |
| E    | 0.1±0.05     |
| F    | 1.2 MAX.     |
| G    | 1.0±0.05     |
| ı    | 18.4±0.1     |
| J    | 0.8±0.2      |
| K    | 0.145±0.05   |
| L    | 0.5          |
| М    | 0.10         |
| N    | 0.10         |
| P    | 20.0±0.2     |
| Q    | 3°+5°<br>-3° |
| R    | 0.25         |
| S    | 0.60±0.15    |
|      |              |

S48GZ-50-MJH-1

#### 48-PIN TAPE FBGA (8x6) (unit: mm)







This package drawing is a preliminary version. It may be changed in the future.



#### **Recommended Soldering Conditions**

Please consult with our sales offices for soldering conditions of the  $\mu$ PD23C32343 and  $\mu$ PD23C32383.

#### **Types of Surface Mount Device**

 $\mu$ PD23C32343GZ-MJH : 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent)

 $\mu$ PD23C32343F9-BC3 : 48-pin TAPE FBGA (8 x 6)

 $\mu$ PD23C32383GZ-MJH : 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent)

 $\mu$ PD23C32383F9-BC3 : 48-pin TAPE FBGA (8 x 6)

#### NOTES FOR CMOS DEVICES —

#### 1 PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

#### 2 HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

#### (3) STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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